

**Search Notes**

Application/Control No.

10/734,283

Examiner

BINH K. TIEU

Applicant(s)/Patent under  
Reexamination

ARCARIA ET AL.

Art Unit

2614

**SEARCHED**

Class	Subclass	Date	Examiner
379	156	11/27/2006	BKT
	159-160		
	162		
	164-165		
	167.01		
	167.02		
	167.04		
	167.06		
	167.07		
	167.08		
↓	167.15	↓	↓

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST DATABASES SEARCHES	11/21/06 11/26/06	BKT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner